

Summary

- Thomson scattering with excellent spatial resolution was applied to negative ion source for the first time.
- Optical system was designed to meet the measurement in the ion source.
- Feasibility of direct measurement of extraction region with Thomson scattering was confirmed with < 0.5 mm spatial resolution at $n_e = 3 \times 10^{16} \text{ m}^{-3}$, which contributes to precise prediction of negative ion trajectory and design of negative ion accelerator.

Introduction

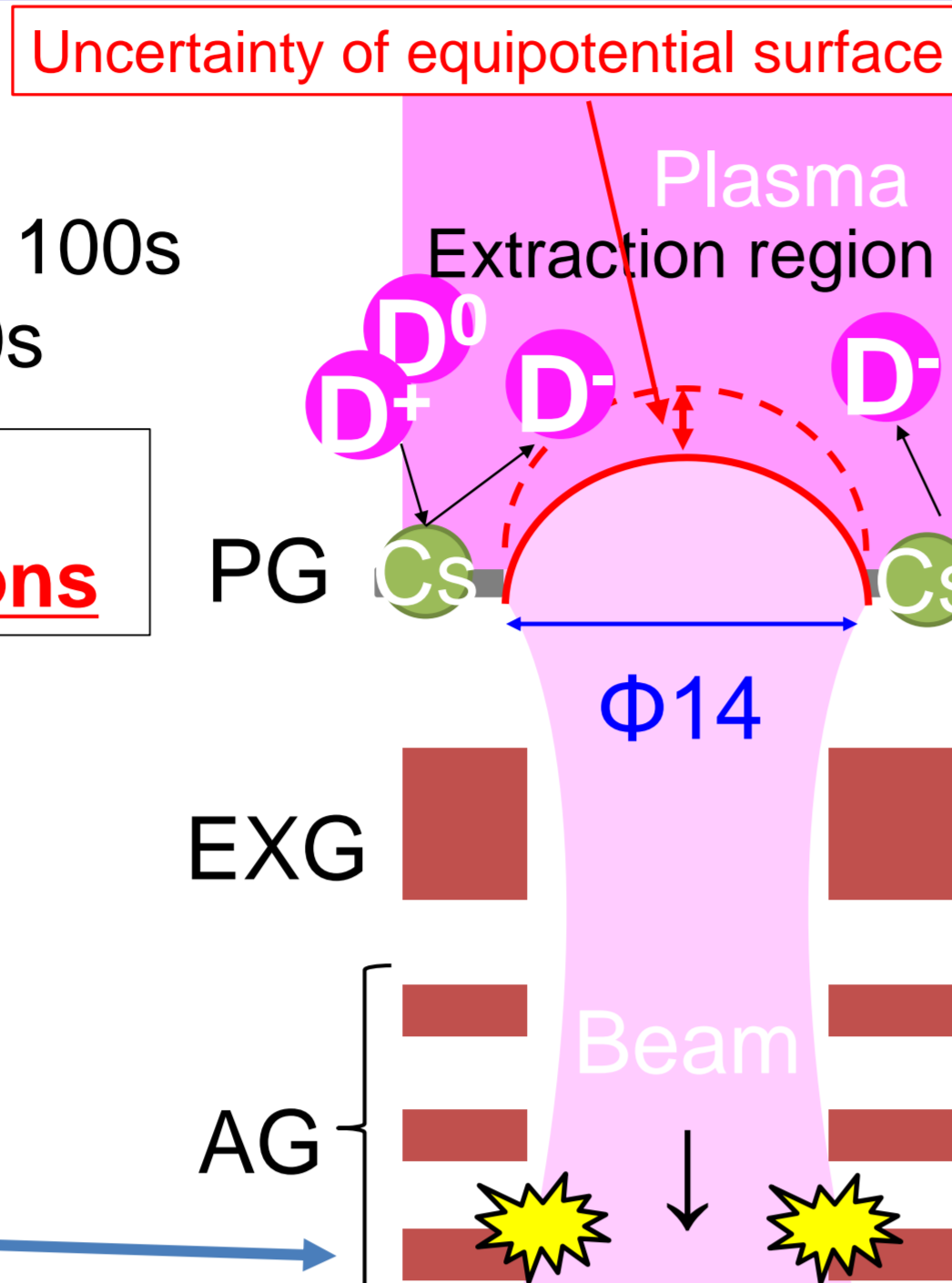
- Target of Long pulse acceleration
- For JT-60SA: 500keV, 130A/m², 100s
 - For ITER: 1MeV, 200A/m², 3600s

Issue: unclear physics of extraction region of negative ions

Conventional simulation of negative ion trajectory and heat load **has not been consistent with experimental result.**



Unexpected trace around beam aperture after beam acceleration



Uncertainty of equipotential surface

Precise prediction of negative ion trajectory
← Understanding potential profile of extraction region

- Different mechanism from positive ion source due to surface production of negative ion
- ⇒ Direct measurement can solve the essential issue of negative ion sources.

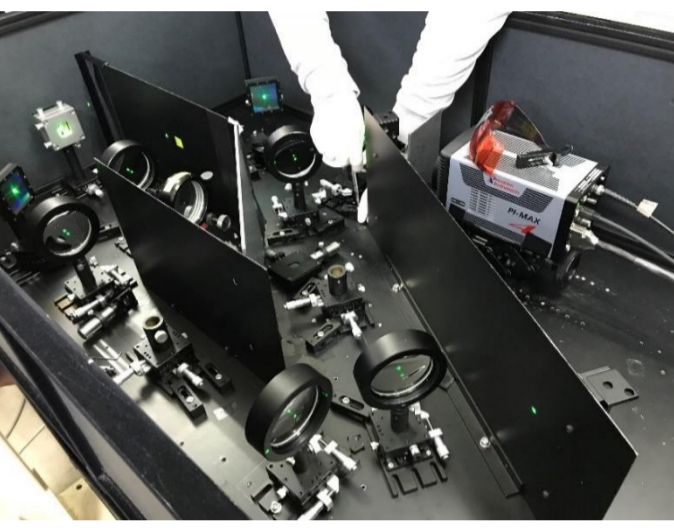
<Challenging Requirements>

- High spatial resolution
- Density profile within 14mm aperture
- Non-disturbance, but direct measurement
- Langmuir probe is unavailable due to high electric field and disturbance of plasma

Direct measurement of extraction region by applying Thomson scattering

Excellent spatial resolution, High sensitivity

- Developed for diagnostics of micro-structure of industrial plasmas
- High spatial resolution (~20μm)
- Non-disturbance measurement



Issue

Original $n_e = 10^{23} \text{ m}^{-3}$

very low density

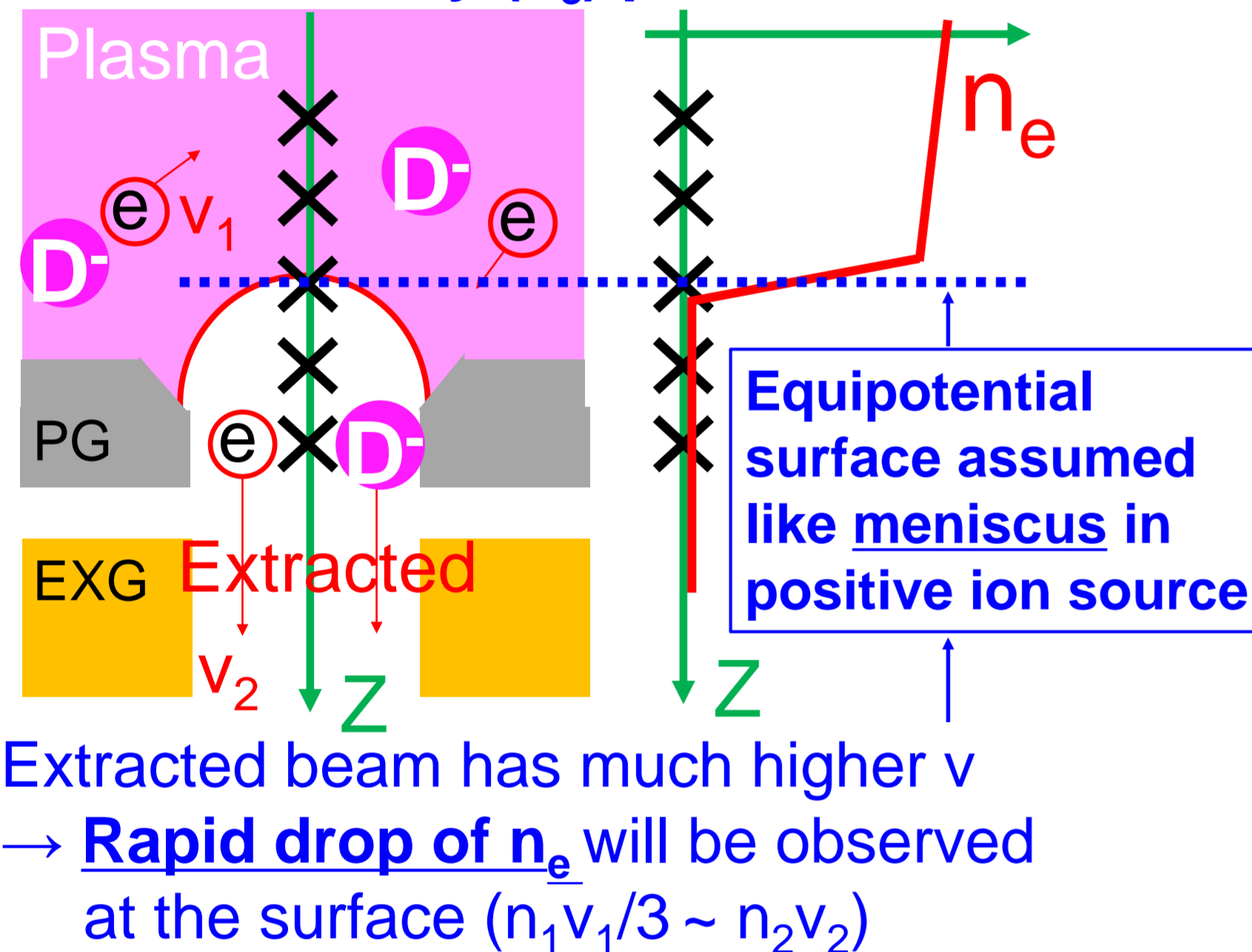
Extraction region $n_e = 10^{16} \text{ m}^{-3}$

Application of Thomson scattering with high spatial resolution developed in Hokkaido-University

K. Tomita, et al., nature scientific reports, 7 12328(2017)

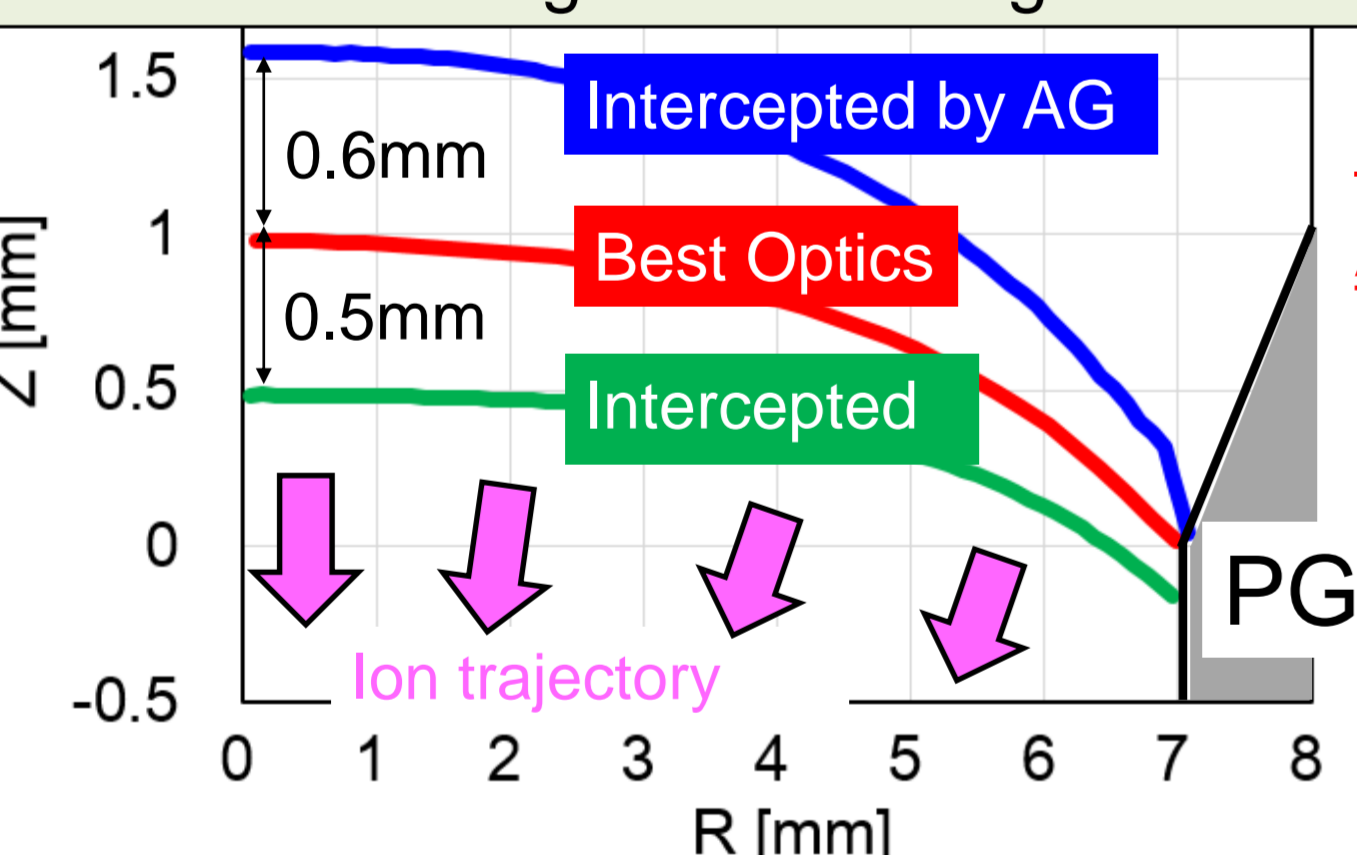
Idea to investigate extraction region

Try to detect **equipotential surface of beam extraction** from measurement of electron density (n_e) profile.



Extracted beam has much higher v
→ **Rapid drop of n_e** will be observed at the surface ($n_1 v_1/3 \sim n_2 v_2$)

Prediction of Meniscus Shape with traditional beam simulation (BEAMORBT) according to Child-Langmuir law

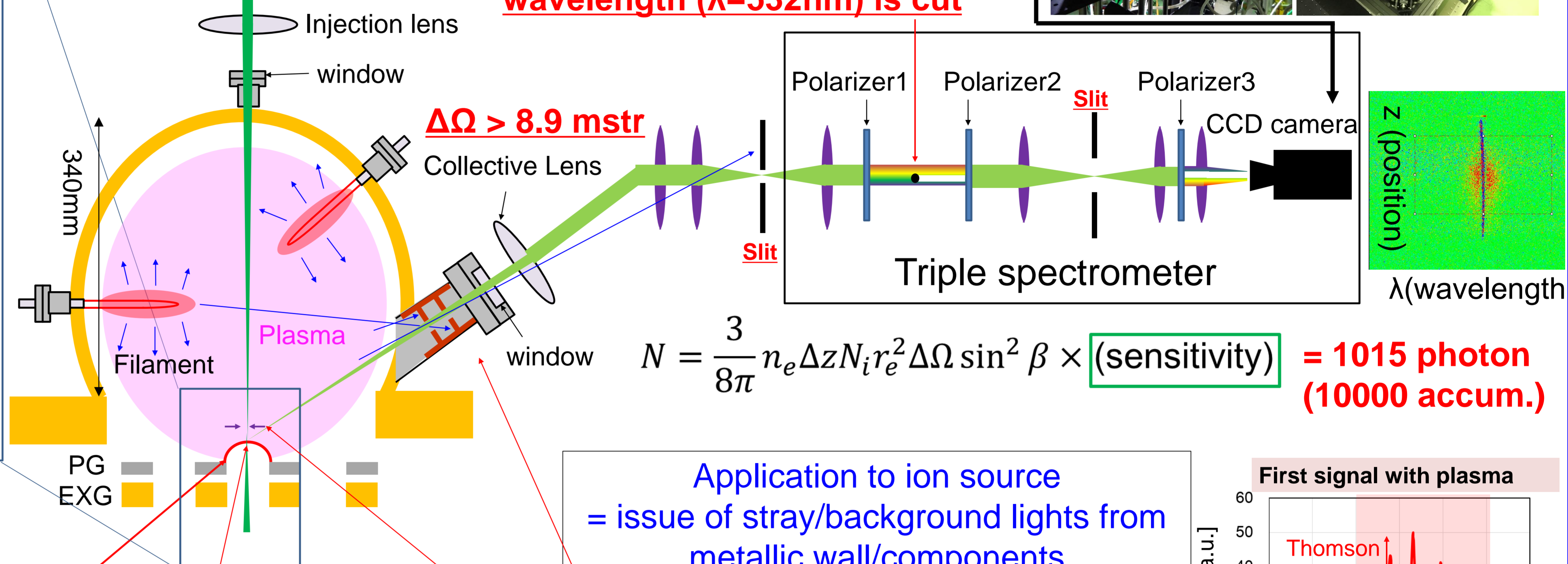


Design of the Thomson scattering measurement

Laser: 300mJ, 532nm, 10Hz ($N_i = 8 \times 10^{17}$ photon)

Synchronization of laser and shutter

Mask → Main stray light of laser wavelength ($\lambda=532\text{nm}$) is cut

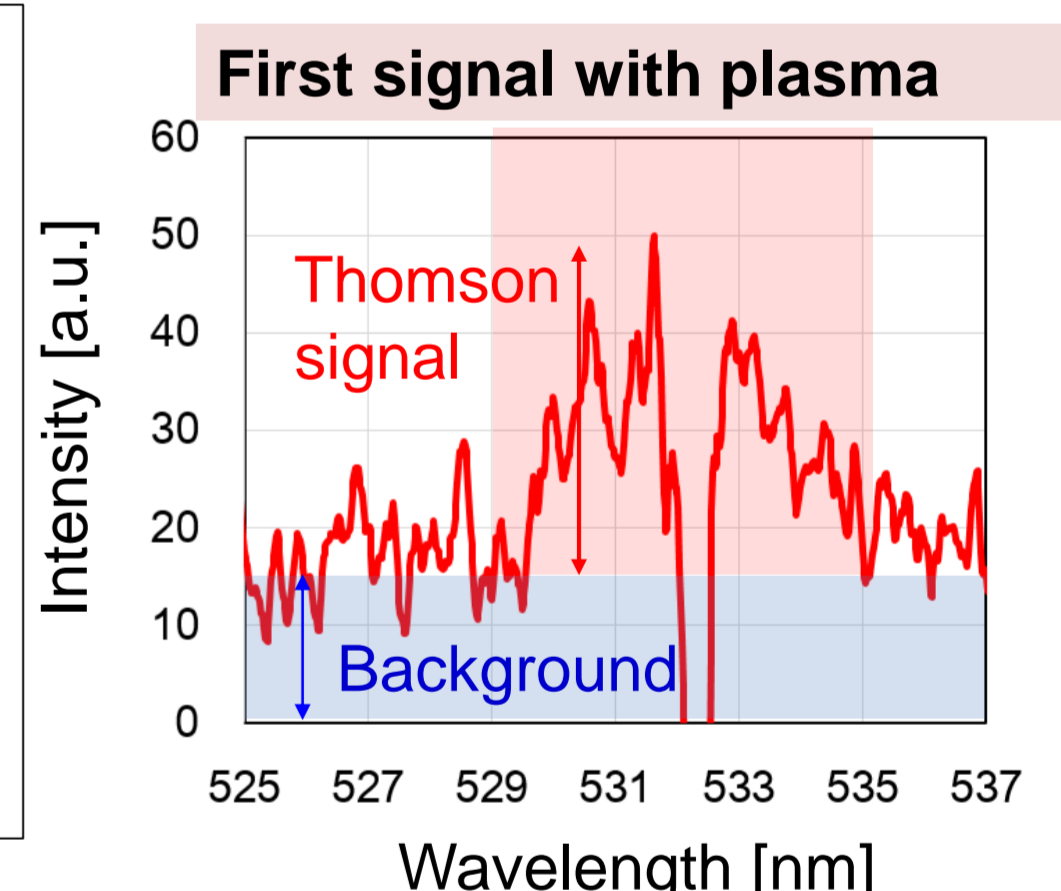


$\Delta\Omega > 8.9 \text{ mstr}$

$$N = \frac{3}{8\pi} n_e \Delta z N_i r_e^2 \Delta\Omega \sin^2 \beta \times (\text{sensitivity}) = 1015 \text{ photon (10000 accum.)}$$

Application to ion source = issue of stray/background lights from metallic wall/components

- Multiple-trap for stray/background lights was introduced.
- Laser beam and slit size was reduced as small as possible (100μm)



$n_e = 3 \times 10^{16} \text{ m}^{-3}$, $\Delta z < 0.5\text{mm}$, error $< 20\%$ is expected with accumulation of shots. (Error is proportional to \sqrt{N} (Poisson distribution)), → **Applicable to meniscus measurement.**

Calibration for resolution and sensitivity check

Calibration with Raman Scattering with Nitrogen gas (200 Pa) for

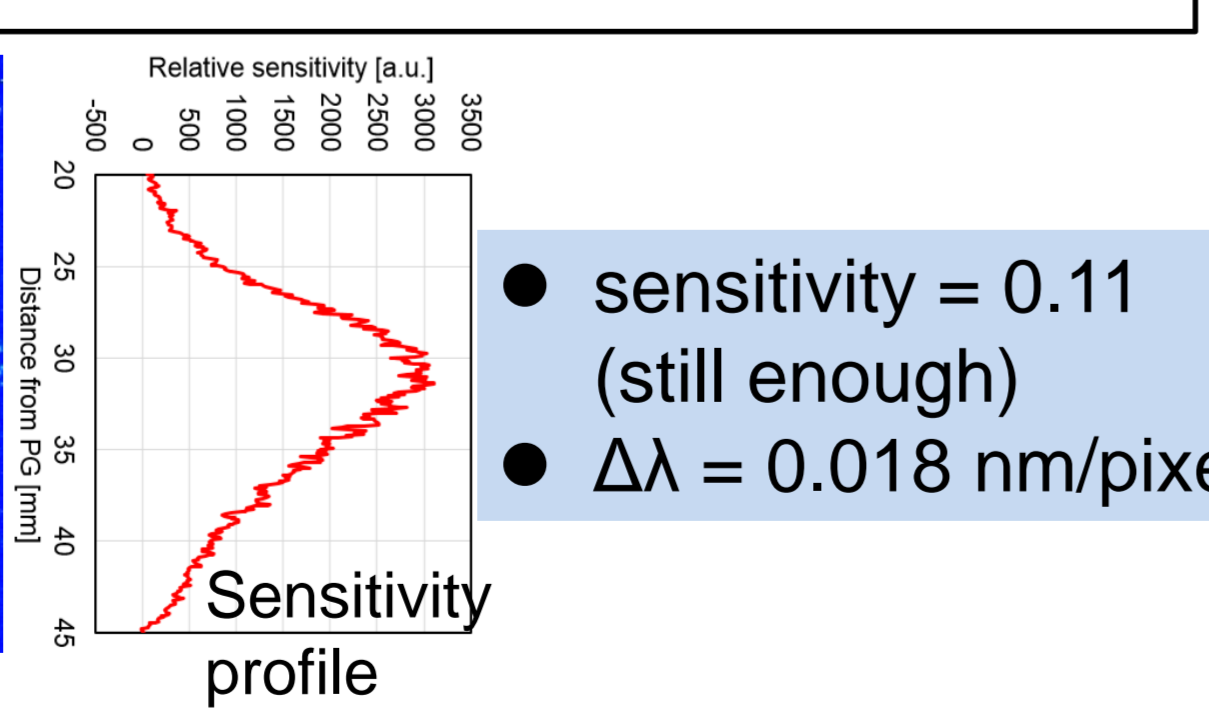
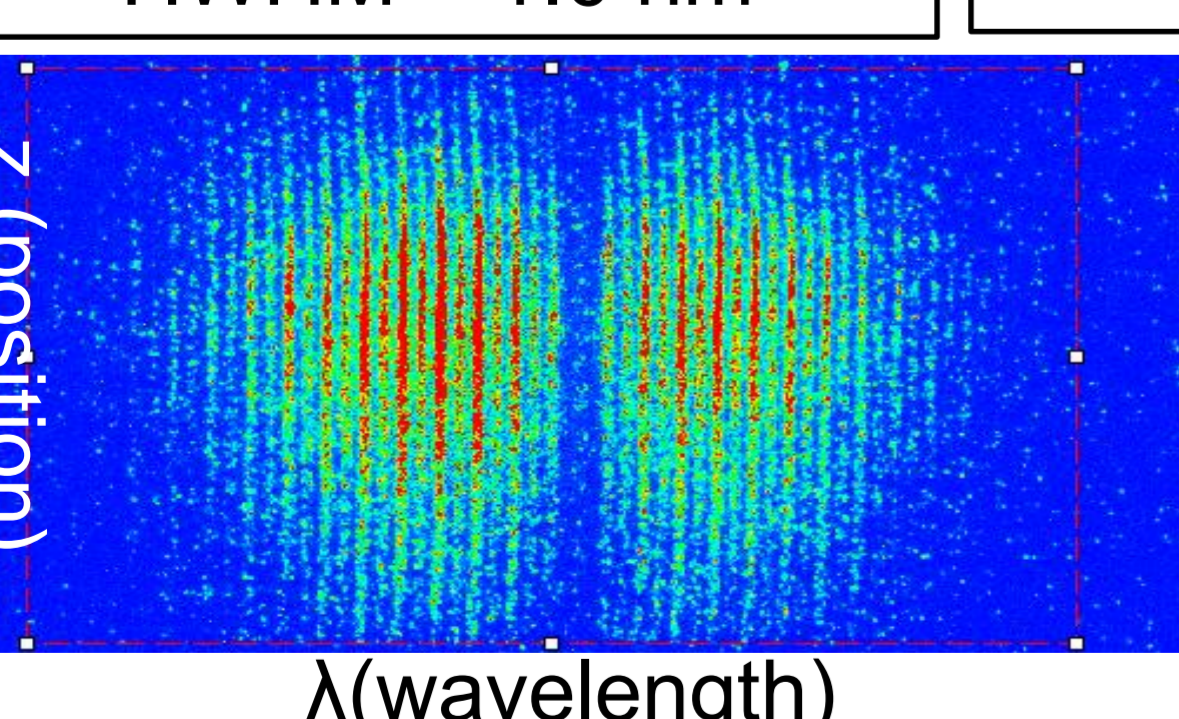
- Absolute sensitivity
- Wavelength resolution
- Confirm cut width

(Absolute sensitivity)

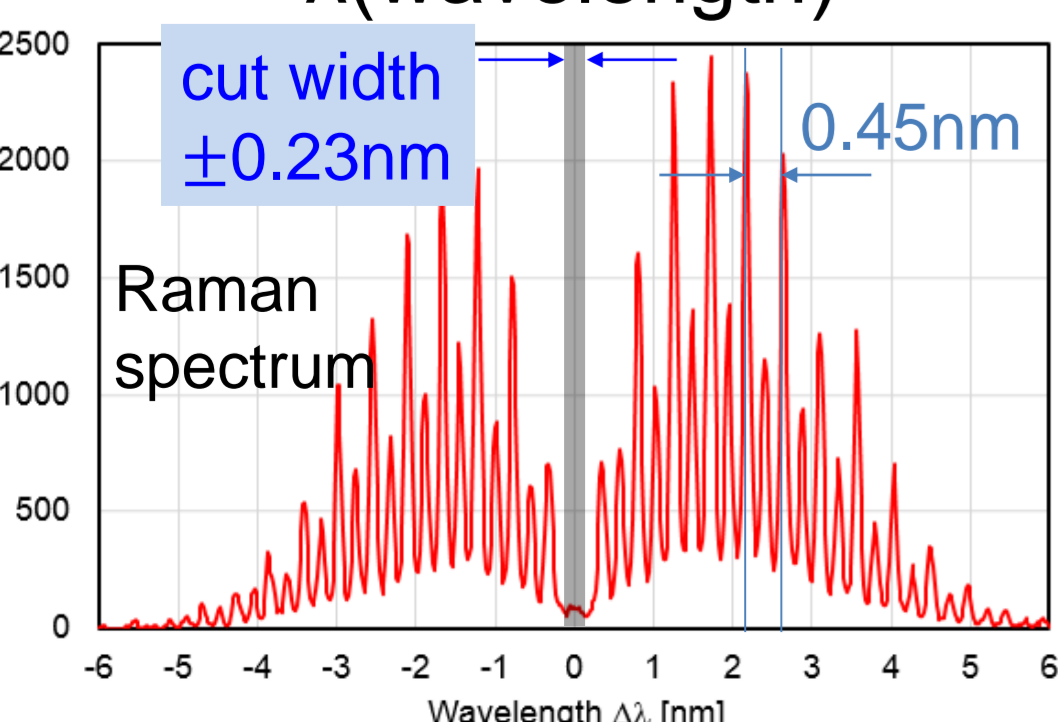
$$\text{Sensitivity} = \frac{\text{Raman signal}}{n(N_2) \times (\text{Raman cross section})}$$

$$n_e = \text{sensitivity} \times (\text{Thomson cross section})$$

(Wavelength resolution)
 $T_e = 0.3 \text{ eV}$
→ HWHM = 1.0 nm



- sensitivity = 0.11 (still enough)
- $\Delta\lambda = 0.018 \text{ nm/pixel}$

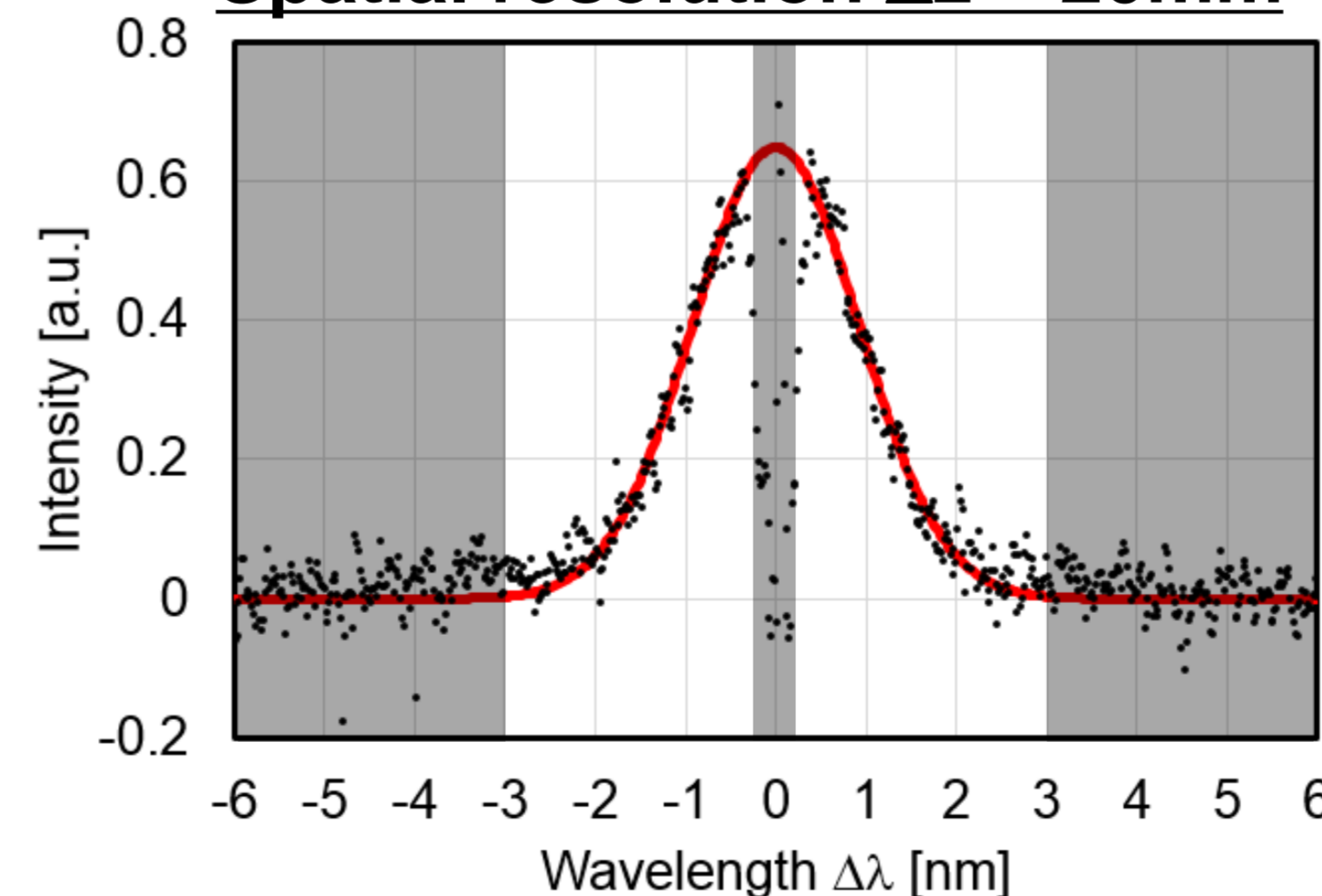


Enough sensitivity and wavelength resolutions for meniscus measurement have been obtained as designed.

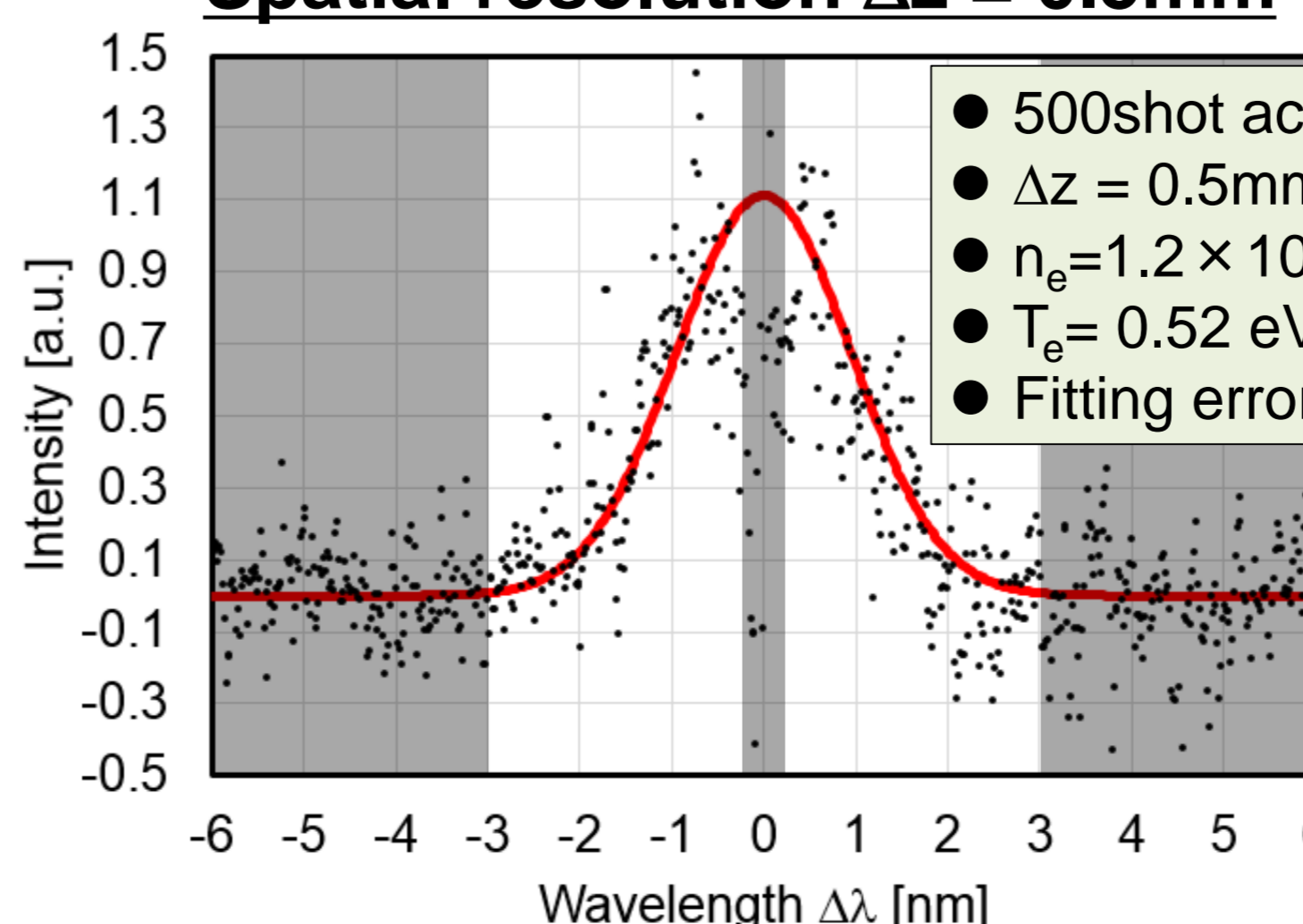
Small cut width enables meniscus measurement up to low temperature

Application to measurement in negative ion source

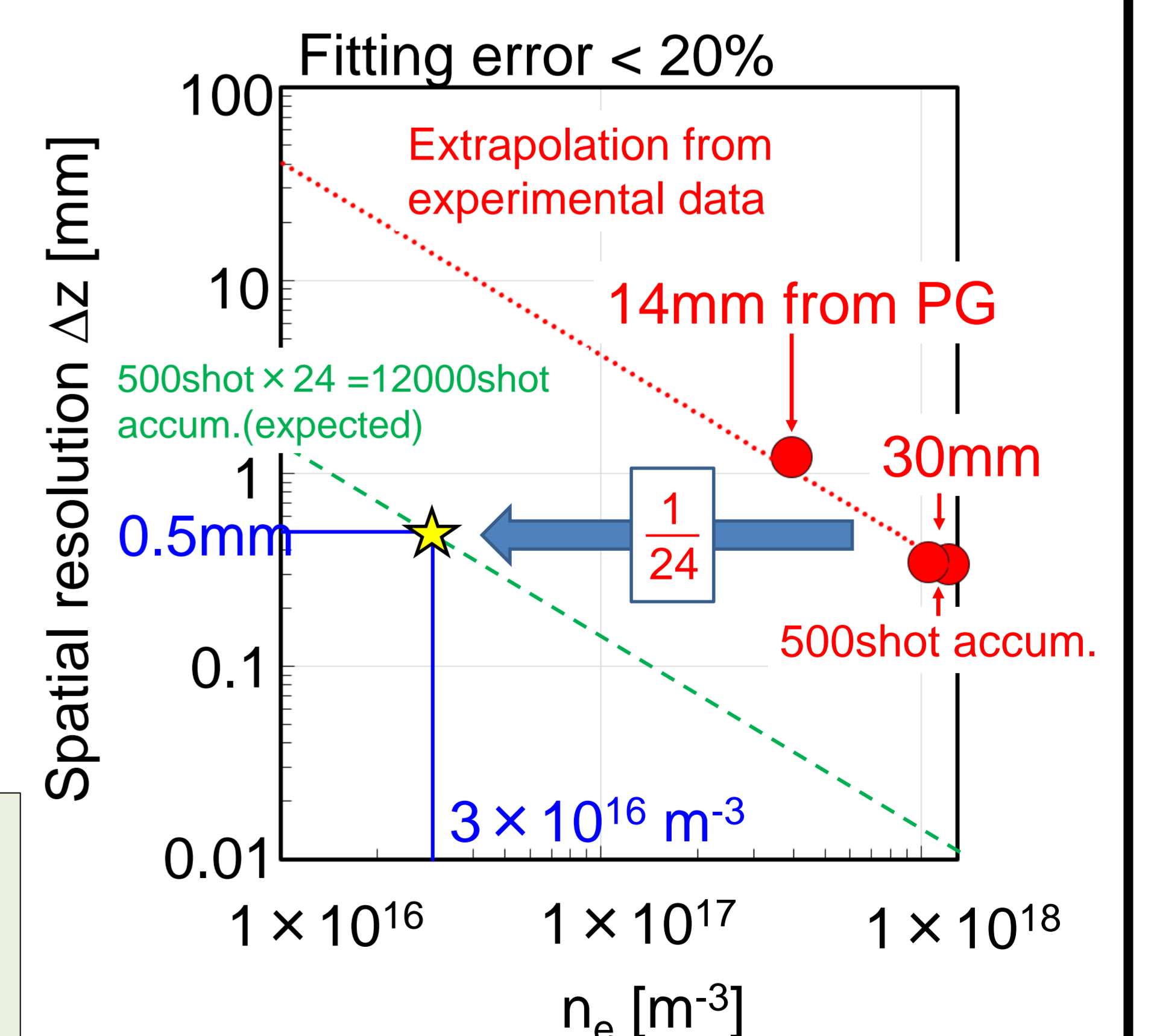
Spatial resolution $\Delta z = 20\text{mm}$



Spatial resolution $\Delta z = 0.5\text{mm}$



- 500shot accum.
- $\Delta z = 0.5\text{mm}$
- $n_e = 1.2 \times 10^{18} \text{ m}^{-3}$
- $T_e = 0.52 \text{ eV}$
- Fitting error = 16.4%



Spatial resolution $< 0.5\text{mm}$ with error $< 20\%$ is achievable by accumulation of > 12000 shots (1200s in total), even in such low-density region.